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LITTE LETES: MANUFACTURE; METHOD; MEMBRANE; FORMING; COMPOSITION;
      INTERLAYER; INSULATE; MEMBRANE; SEMICONDUCTOR; ELEMENT; ONE; KIND; SILANE
      ; COMPOUND; HYDROLYSIS; PRESENCE; NITROGEN; ONIUM; SALT
    Derwent Class: A26; A85; E11; G02; L03; U11
    International Patent Class (Main): CO9D-183/04
    International Patent Class (Additional): CO9D-183/02; CO9D-183/14
    File Segment: CPI; EPI
 \rightarrow 1/5/2
   DIALOG(R) File 352: Derwent WPI
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                **Image available**
   WPI Acc No: 2002-133815/200218
   XRAM Acc No: C02-041195
   XRPX Acc No: NO2-101222
     Film for interlayer insulating film, used in semiconductor elements, has
     specific film density
   Patent Assignee: JSR CORP (JAPS )
   Number of Countries: 001 Number of Patents: 001
   Patent Family:
   Patent No
                Kind
                        Date
                                Applicat No Kind
                                                      Date
                                                               Week
   JP 2001203197 A 20010727 JP 200012513
                                              A
                                                    20000121 200218 B
   Priority Applications (No Type Date): JP 200012513 A 20000121
   Patent Details:
   Patent No Kind Lan Pg Main IPC
                                        Filing Notes
   JP 2001203197 A 20 H01L-021/312
   Abstract (Basic): JP 2001203197 A
           NOVELTY - A film has a film density of 0.5 - 1.4 g/cm3.
                                    kekka. TXT
           DETAILED DESCRIPTION - The film consists of formula (1).
           x=1.3 - 1.9;
           y=0.2 - 8.0;
           z=0.6-7.0
           USE - The method forms the film for an interlayer insulating film
       for use in a semiconductor element.
           ADVANTAGE - The film has superior dielectric constant and
       mechanical strength.
           pp; 20 DwgNo 0/0
   Title Terms: FILM; INTERLAYER; INSULATE; FILM; SEMICONDUCTOR; ELEMENT;
    SPECIFIC; FILM; DENSITY
  Derwent Class: A82; A85; G02; L03; U11
   International Patent Class (Main): HOLL-021/312
   International Patent Class (Additional): CO9D-005/25; CO9D-183/06;
    H01L-021/316
  File Segment: CPI; EPI
\rightarrow 1/5/3
  DIALOG(R) File 352: Derwent WPI
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  014270872
  WPI Acc No: 2002-091573/200213
  Related WPI Acc No: 2002-149260
  XRAM Acc No: C02-028431
    Composition for film formation, comprises product obtained by hydrolyzing
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and condensing at least one silane compound and an organic solvent